NSN 5962-01-212-3410

Digital Microcircuit - Page 1 of 1



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Body Length: Between 0.885 inches and 0.915 inches Body Width: Between 0.285 inches and 0.305 inches Body Height: Between 0.120 inches and 0.130 inches Operating Tempurature Range: -55.0 to 125.0 degrees celsius Storage Tempurature Range: -65.0 to 150.0 degrees celsius Storage Tempurature Range: -65.0 to 150.0 degrees celsius Features Provided: High speed and schottky and w/enable and 3-state output Inclosure Material: Ceramic Inclosure Configuration: Dual-in-line Output Logic Form: Transistor-transistor logic Imput Circuit Pattern: 12 input Time Rating Per Chacteristic: 90.00 nanoseconds propagation delay time, low to high level output and 90.00 nanoseconds propagation delay time, high to low level output Shelf Life: N/a Unit Of Measure:	
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